

#### **40V P-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> max T <sub>A</sub> = 25°C	
-40V	80mΩ @ V <sub>GS</sub> = -10V	-3.7 A	
	150mΩ @ V <sub>GS</sub> = -4.5V	-2.8 A	

### **Description and Applications**

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor control
- DC-DC Converters
- Power management functions
- Uninterrupted power supply

### **Features and Benefits**

- Fast switching speed
- Low gate drive
- Low gate drive
   Low input capacitance
- "Lead Free", RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

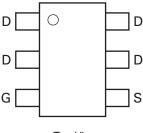
#### **Mechanical Data**

- Case: SOT26
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper lead frame.
   Solderable per MIL-STD-202, Method 208
- Weight 0.018 grams (approximate)

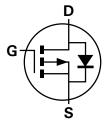




Top View



Top View Pin-Out



**Equivalent Circuit** 

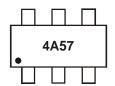
### Ordering Information (Note 3)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMP4A57E6TA	4A57	7	8	3.000

Notes:

- 1. No purposefully added lead
- 2. Diodes Inc's "Green" policy can be found on our website at http://www.diodes.com.
- 3. For packaging details, go to our website at http://www.diodes.com.

### **Marking Information**



4A57 = Product Type Marking Code





### Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic			Symbol	Value	Unit V V
Drain-Source voltage Gate-Source voltage		V <sub>DSS</sub> V <sub>GS</sub>	-40 ±20		
Continuous Drain current	$V_{GS} = 10V$	$T_A = 70^{\circ}C$ (Note 5)	I <sub>D</sub>	-2.9	Α
		(Note 4)		-2.9	
Pulsed Drain current	$V_{GS} = 10V$	(Note 6)	I <sub>DM</sub>	-18	А
Continuous Source current (Body diode) (Note 5)		I <sub>S</sub>	-2.6	Α	
Pulsed Source current (Body diode) (Note 6)		I <sub>SM</sub>	-18	Α	

# Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit	
Power dissipation	(Note 4)	9	1.1 8.8	W	
Linear derating factor	(Note 5)	P <sub>D</sub>	1.7 13.7	mW/°C	
Thermal Resistance, Junction to Ambient	(Note 4)	D.	113	°C/W	
Thermal Resistance, Junction to Ambient	(Note 5)	$R_{\thetaJA}$	73	C/VV	
Operating and storage temperature range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	

Notes:

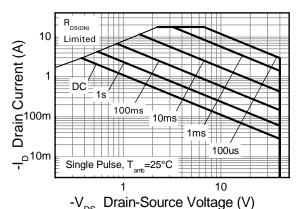
<sup>4.</sup> For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

<sup>5.</sup> Same as note (4), except the device is measured at  $t \le 5$  sec.

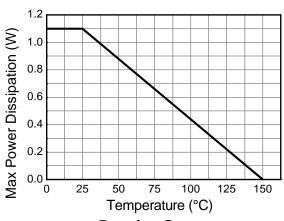
<sup>6.</sup> Same as note (4), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.



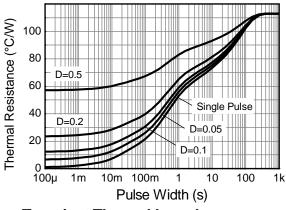
### **Thermal Characteristics**



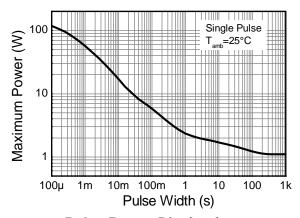
 $-V_{DS}$  Drain-Source Voltage (V) **P-channel Safe Operating Area** 



**Derating Curve** 



**Transient Thermal Impedance** 



**Pulse Power Dissipation** 





# Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

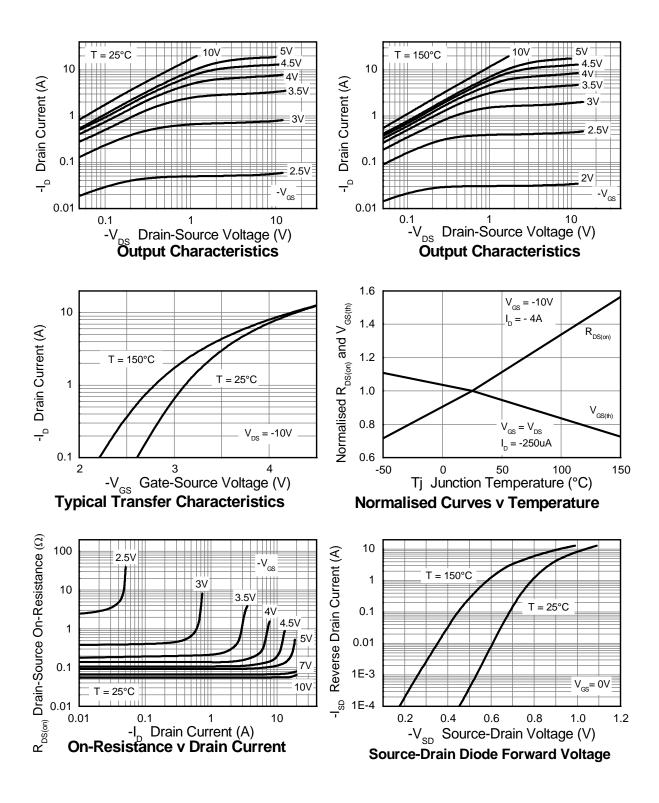
Characteristic	Symbol	Min	Тур	Max	Unit	Test Co	ondition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-40			V	$I_D = -250 \mu A, V_{GS} = 0V$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-0.5	μΑ	$V_{DS} = -40V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS}$	= 0V
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1.0	_	-3.0	V	$I_D = -250 \mu A, V_{DS}$	= V <sub>GS</sub>
Ctatic Dunin Course On Desigtance (Nate 7)		_	_	0.080		$V_{GS} = -10V, I_{D} =$	-4A
Static Drain-Source On-Resistance (Note 7)	R <sub>DS(on)</sub>		_	0.150	Ω	$V_{GS} = -4.5V, I_{D} =$	-2A
Forward Transconductance (Notes 7 & 8)	9fs		7.6	_	S	$V_{DS} = -15V, I_{D} =$	-4A
Diode Forward Voltage (Note 7)	$V_{SD}$	_	-0.86	-0.95	V	I <sub>S</sub> = -4A, V <sub>GS</sub> = 0V	
Reverse recovery time (Note 8)	t <sub>rr</sub>		17.4	_	ns	I <sub>S</sub> = -1.8A, di/dt = 100A/μs	
Reverse recovery charge (Note 8)	Q <sub>rr</sub>	_	11.1	_	nC		
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>		833			$V_{DS} = -20V, V_{GS} = 0V$ f = 1MHz	
Output Capacitance	Coss		122	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	78	_			
Total Gate Charge (Note 9)	Qg	_	7	_		$V_{GS} = -4.5V$	
Total Gate Charge (Note 9)	Qq	_	15.8	_		V <sub>DS</sub> = -20V	
Gate-Source Charge (Note 9)	Q <sub>qs</sub>		3.6	_	nC	$V_{GS} = -10V$ $I_{D} = -4A$	$I_D = -4A$
Gate-Drain Charge (Note 9)	$Q_{gd}$	_	2.7	_			
Turn-On Delay Time (Note 9)	t <sub>D(on)</sub>	_	2.5	_		V <sub>DD</sub> = -20V, V <sub>GS</sub> = -10V	
Turn-On Rise Time (Note 9)	t <sub>r</sub>		3.3	_			
Turn-Off Delay Time (Note 9)	t <sub>D(off)</sub>	_	47	_	ns $I_D = -1A$ , $R_G \cong 6.0\Omega$		ΩΩ
Turn-Off Fall Time (Note 9)	t <sub>f</sub>		21	_			

Notes:

- Measured under pulsed conditions. Pulse width ≤ 300μs; duty cycle ≤ 2%
   For design aid only, not subject to production testing.
   Switching characteristics are independent of operating junction temperatures.

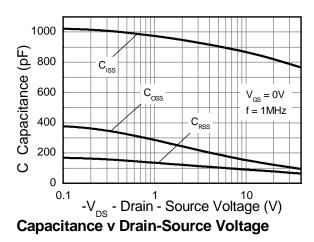


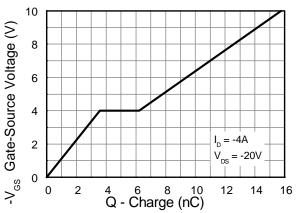
# **Typical Characteristics**





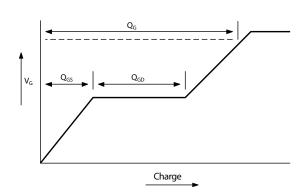
# **Typical Characteristics - continued**



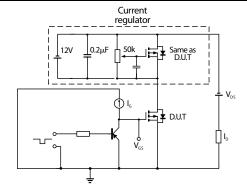


**Gate-Source Voltage v Gate Charge** 

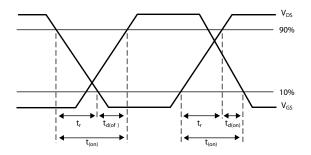
### **Test Circuits**



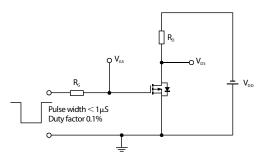
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

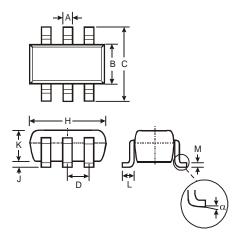


Switching time test circuit



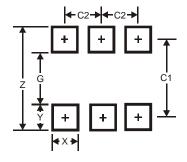


# **Package Outline Dimensions**



SOT-26					
Dim	Min	Max	Тур		
Α	0.35	0.50	0.38		
В	1.50	1.70	1.60		
С	2.70	3.00	2.80		
D	_	_	0.95		
Н	2.90	3.10	3.00		
J	0.013	0.10	0.05		
K	1.00	1.30	1.10		
L	0.35	0.55	0.40		
М	0.10	0.20	0.15		
α	0°	8°	_		
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)
Z	3.20
G	1.60
Х	0.55
Y	0.80
C1	2.40
C2	0.95





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